

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/738,910	DARDIK ET AL.	
Examiner	Art Unit	
John P. Sheehan	1742	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DAT	
EAST	8/28/2	006 JS
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